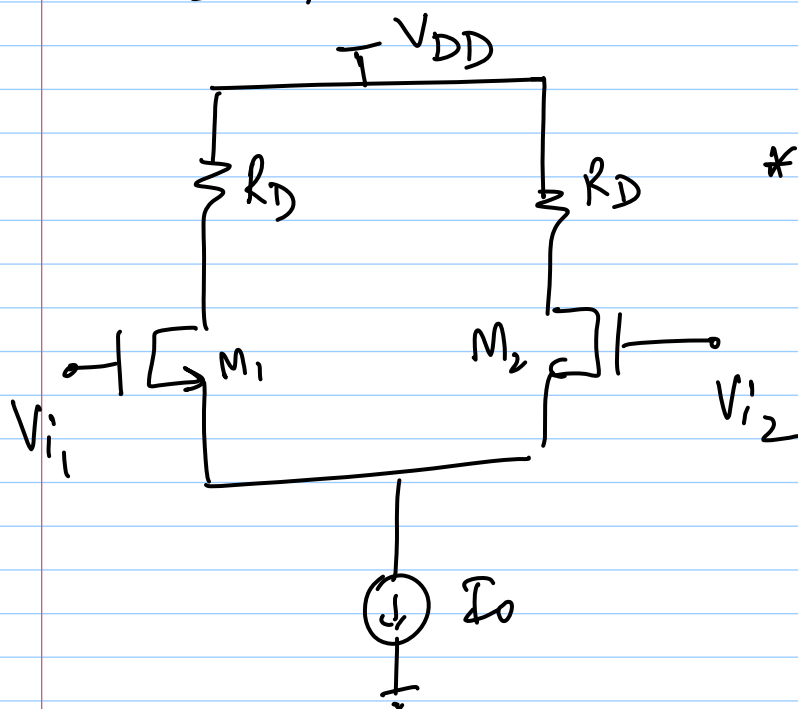


13/1/12

Lec 7

Diff pairs



$V_{i1} - V_{as1} + V_{as2} - V_{i2} = 0$
 * Assume M_1, M_2 in sat. and identical

$$V_{as1} = V_T + \sqrt{\frac{2I_{D1}}{k'(W/L)}}$$

$$V_{as2} = V_T + \sqrt{\frac{2I_{D2}}{k'(W/L)}}$$

$$V_{id} = V_{i1} - V_{i2} = V_{as1} - V_{as2}$$

$$V_{id} = \frac{\sqrt{I_{D1}} - \sqrt{I_{D2}}}{\sqrt{\frac{1}{2}k'(W/L)}} \quad \text{--- (1)}$$

$$\text{also } I_{D1} + I_{D2} = I_0 \quad \text{--- (2)}$$

solve quadratic equation...

$$I_{D1} = \frac{I_0}{2} + \frac{k'}{4} \left(\frac{W}{L} \right) V_{id} \sqrt{\frac{4I_0}{k'(W/L)} - V_{id}^2}$$

DC bias value

$$V_{ov} = V_{GS} - V_T \rightarrow V_{DSAT} = \sqrt{\frac{2 \cdot (I_0/2)}{k' (W/L)}} = \sqrt{\frac{I_0}{k' (W/L)}}$$

$$g_m = k' \left(\frac{W}{L} \right) (V_{GS} - V_T) = k' \left(\frac{W}{L} \right) V_{DSAT}$$

$$\therefore I_{D1} = \frac{I_0}{2} + \frac{k'}{4} \frac{W}{L} V_{id} \sqrt{4V_{DSAT}^2 - V_{id}^2}$$

$$= \frac{I_0}{2} + \frac{1}{2} \cdot g_m V_{id} \sqrt{1 - \left(\frac{V_{id}}{2V_{DSAT}} \right)^2}$$

$$I_{D2} = \frac{I_0}{2} - \frac{1}{2} g_m V_{id} \sqrt{1 - \left(\frac{V_{id}}{2V_{DSAT}} \right)^2}$$

for "small" signals:

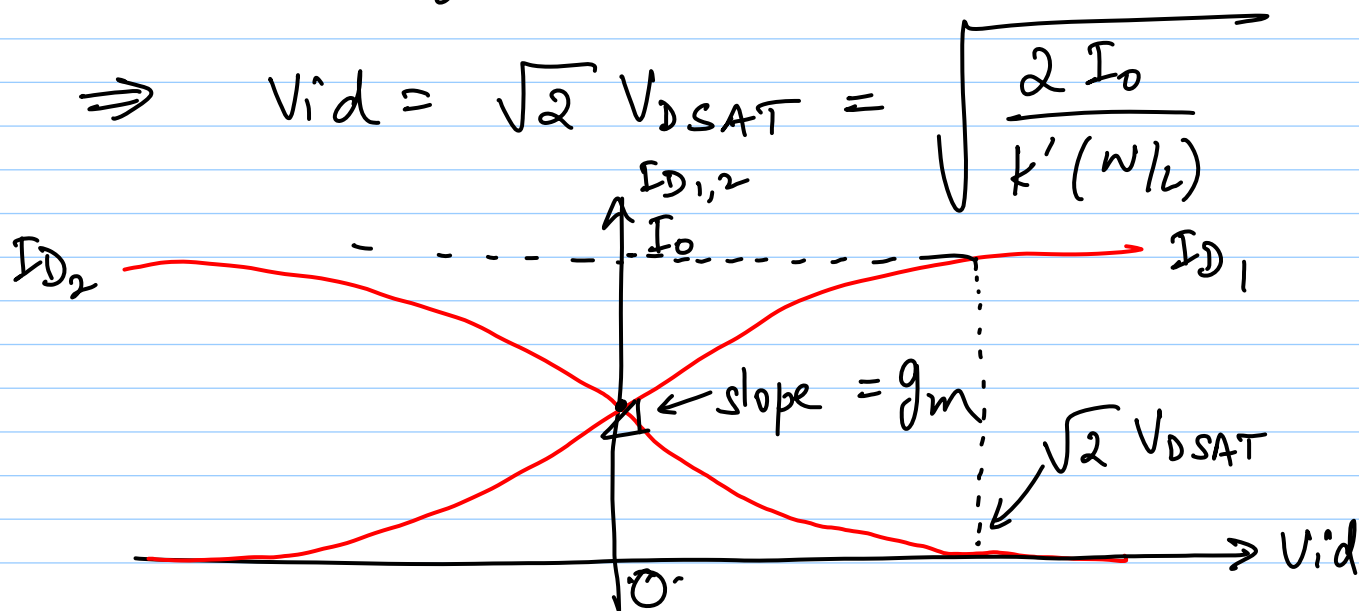
i.e. $V_{id} \ll 2V_{DSAT}$

$$\Delta I_D = g_m V_{id} \Rightarrow \boxed{v_{out} = g_m R_D V_{id}}$$

$I_{D1} = I_0$ (full switching)
when M_2 is off

$$G_m = \frac{\partial \Delta I_D}{\partial V_{id}} \leftarrow \text{set this to } \underline{\text{zero}}$$

$$\Rightarrow V_{id} = \sqrt{2} V_{DSAT} = \sqrt{\frac{2 I_0}{k' (W/L)}}$$



Large-signal analysis

→ used to quantify linearity

performance of analog cts.

Can signal size be reduced arbitrarily?

→ No, because of effects of noise

Noise

- any random interference unrelated to signal of interest
- represents inherent uncertainties @ physical level
- Use PDF (prob. dens. fn.) to represent statistical quantity

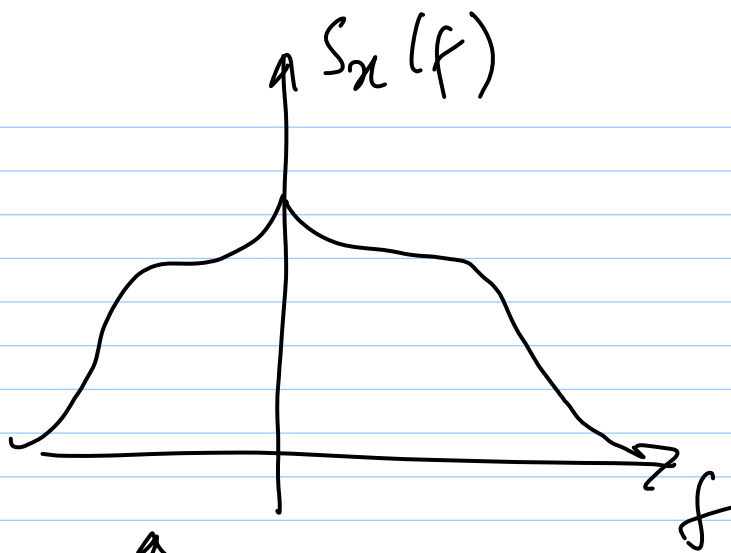
* typically interested in "mean square power" of noise

$$\overline{n^2(t)}$$

* power spectral density PSD

is used to represent noise in f -domain

$S_x(f)$ = noise power in a unit BW around f

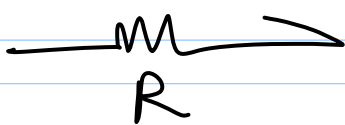


2-sided
even fn' of f
 $S_n(f) = S_n(-f)$
* used in graph.
analysis



-ve portion
is "folded" over
* used in clct
calculations

1) Resistor - thermal noise

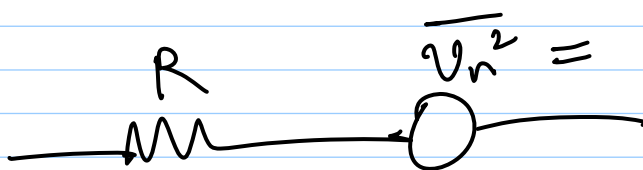


$$S_n(f) = 2kTR$$

↑
abs. temp

Boltzmann's
const.

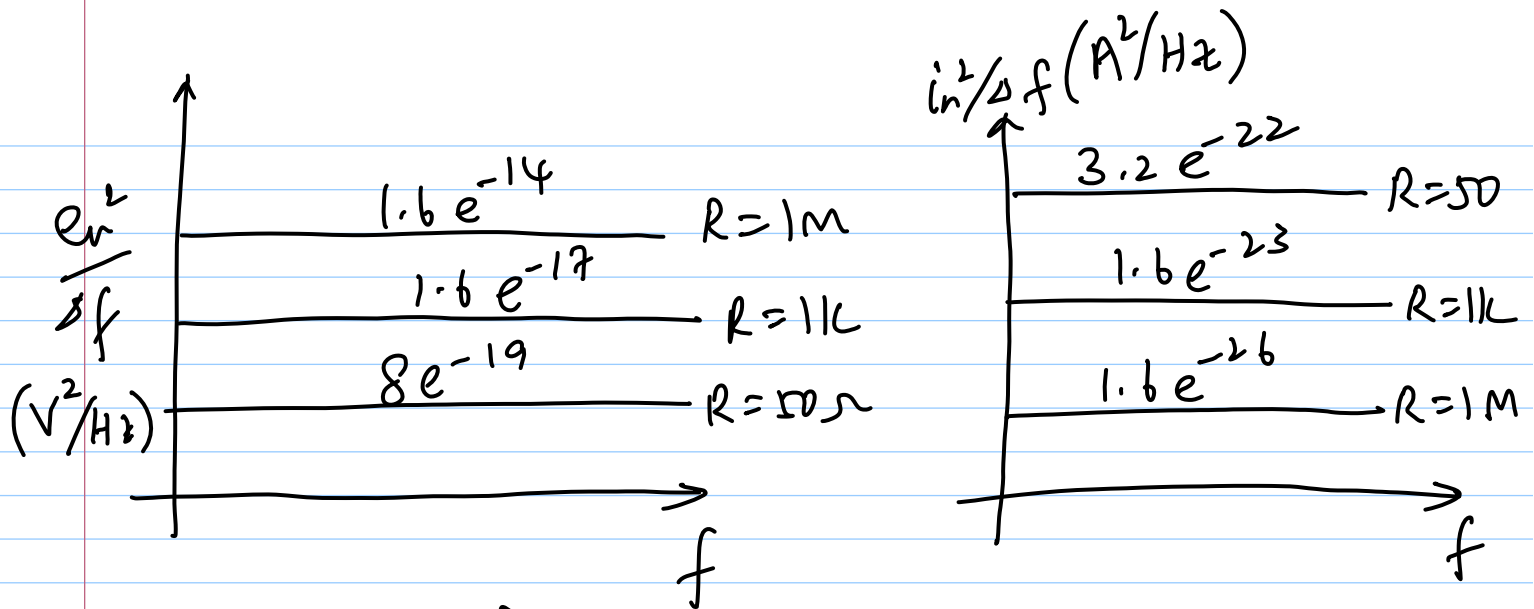
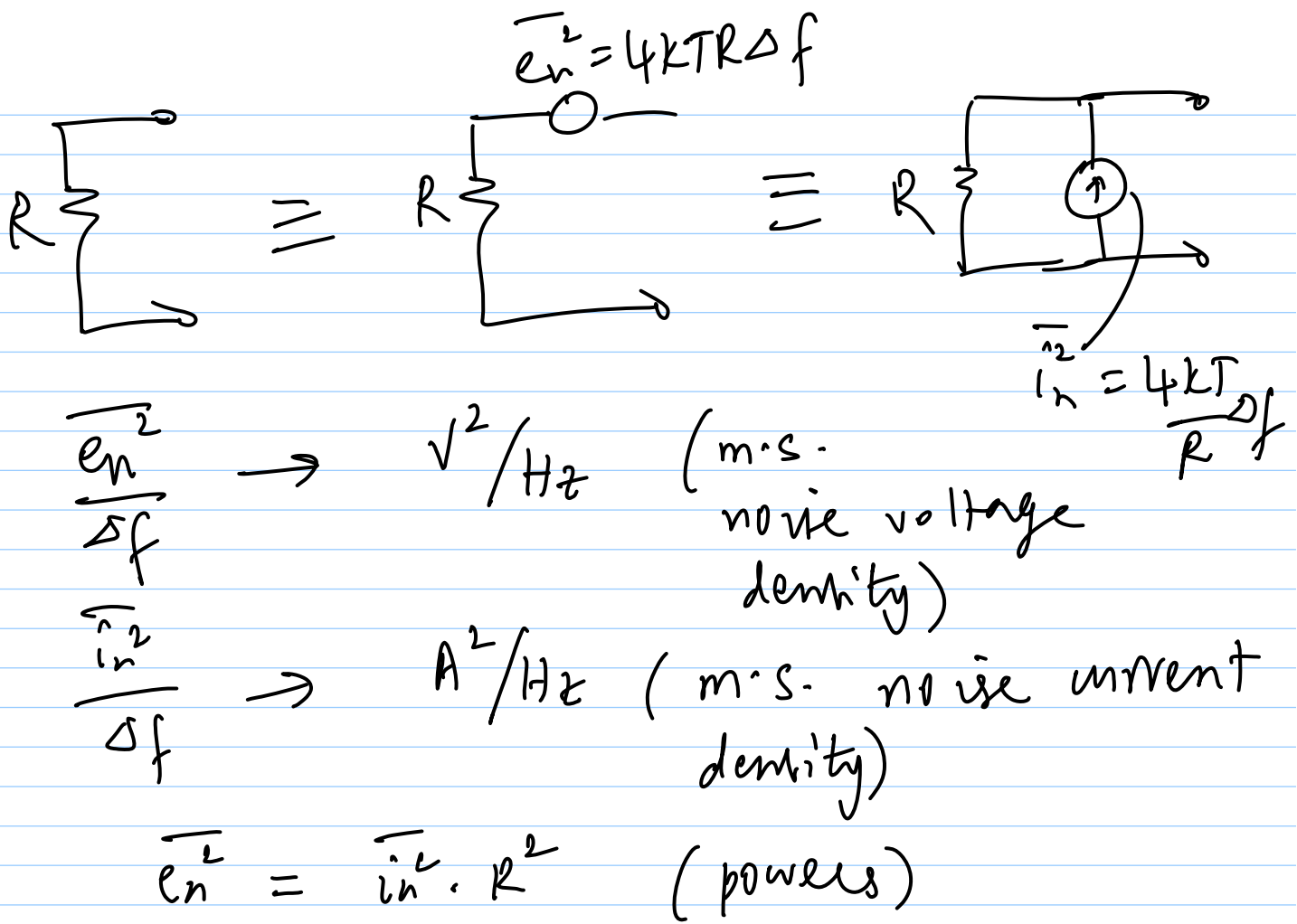
In clct calculations



$$\overline{v_n^2} = 4kTR \Delta f$$

(
mean square
noise voltage

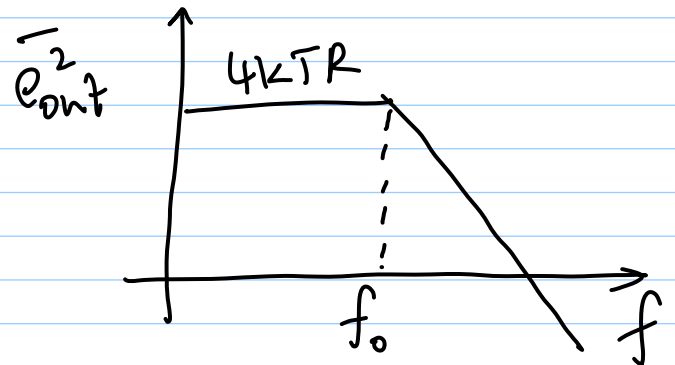
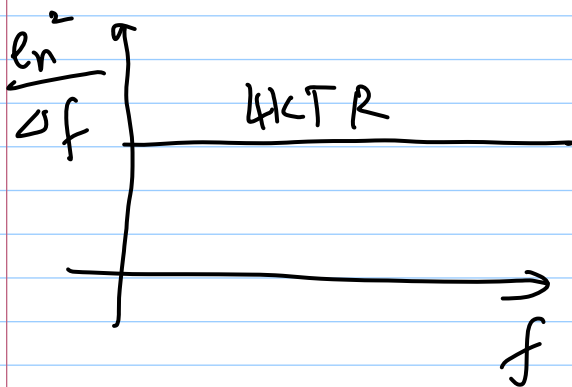
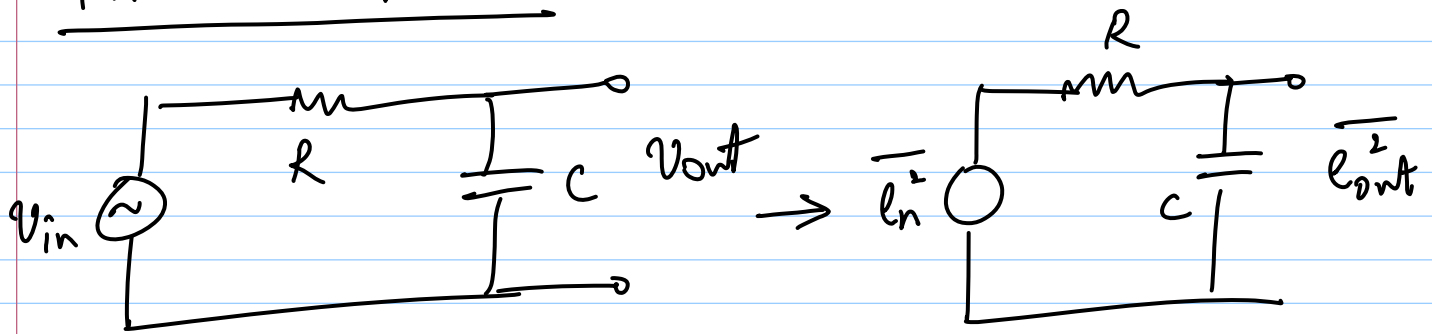
$\Delta f = \text{BW of interest}$



- * Spot noise = mean sq. noise density integrated over 1 Hz BW @ freq. of interest
- * White noise - Spot noise is independent of freq.

$$1k\Omega \leftrightarrow 4nV/\sqrt{Hz}$$

Filtered Noise:



$$f_0 = \frac{1}{2\pi RC}$$

* Noise Low-pass-filtered

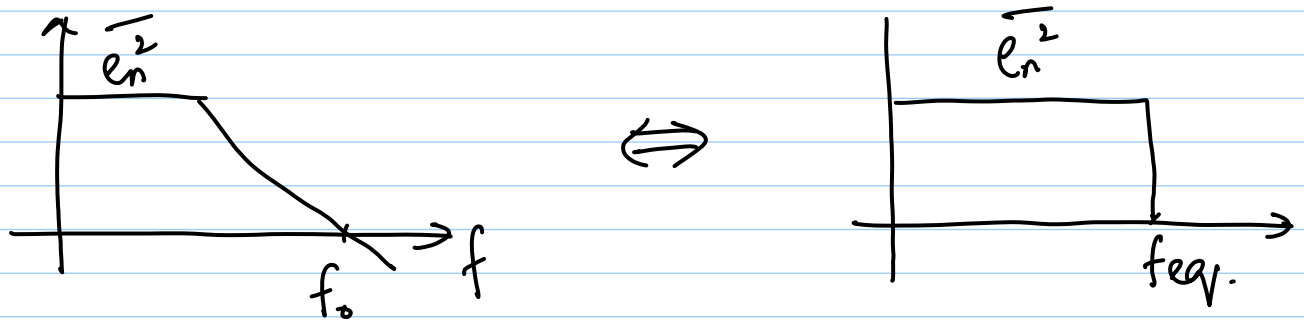
* Integrated m.s. noise:

$$\bar{e}_{out,int}^2 = \int_0^{\infty} \frac{\bar{e}_n^2}{|1 + j2\pi fRC|^2} df$$

$$= \frac{\bar{e}_n^2}{2\pi RC} \cdot \frac{\pi}{2}$$

$$\boxed{\bar{e}_{out,int}^2 = kT/C \text{ V}^2}$$

* Equivalent noise BW = BW of brick-wall filter whose o/p integ. noise is same as the above 1-pole LPF



$$\frac{KT}{C} = \overline{e_n^2} \cdot f_{eq} = 4KTR \cdot f_{eq}$$

$$f_{eq} = \frac{1}{4RC} = \frac{\pi}{2} \cdot f_0$$